IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

10/06071 10/06071

Group Art Unit:

Examiner:

In re the application of: Joseph R. Siegel

Serial No.: N/A

Filed: Herewith

For: SCANABLE R-S GLITCH LATCH FOR

DYNAMIC CIRCUITS

Attorney Docket No.: SMQ-046/P5339

Commissioner for Patents Washington, D.C. 20231

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Date of Deposit January 30, 2002

I hereby certify that this paper or fee is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 CFR 10 on the date indicated above and is addressed to the Commissioner for Patents,

Washington, DC 20231

Signature

Larry Taylor

Please Print Name of Person Signing

INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Applicant and his Attorney are aware of the following publication, listed on the attached PTO Form 1449, and in accordance with 37 CFR §1.97 hereby submit this publication for the Examiner's consideration. A copy of the cited publication is enclosed.

SMQ-046/P5339

This statement is not to be interpreted as a representation that the cited

publication is material, that an exhaustive search has been conducted, or that no other

relevant information exists. Nor shall the citation of the publication herein be construed

per se as a representation that such publication is prior art. Moreover, Applicant

understands that the Examiner will make an independent evaluation of the cited

publication.

No additional costs are believed to be due in connection with the filing of this

Information Disclosure Statement. However, please charge any necessary fees in

connection with the enclosed statement to our Deposit Order Account No. 12-0080.

Respectfully submitted,

LAHIVE & COCKFIELD, LLP

Kevin J. Canning

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Date: January 30, 2002

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Enclosure

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